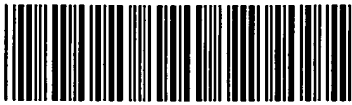


Search Notes

Application/Control No.

09/346,719

Examiner

Alain L. Bashore

Applicant(s)/Patent under
Reexamination

ANAYA ET AL.

Art Unit

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SEARCHED

| Class | Subclass | Date | Examiner |
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**SEARCH NOTES
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| | DATE | EXMR |
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| previous search updated | 10/6/2005 | AB |
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